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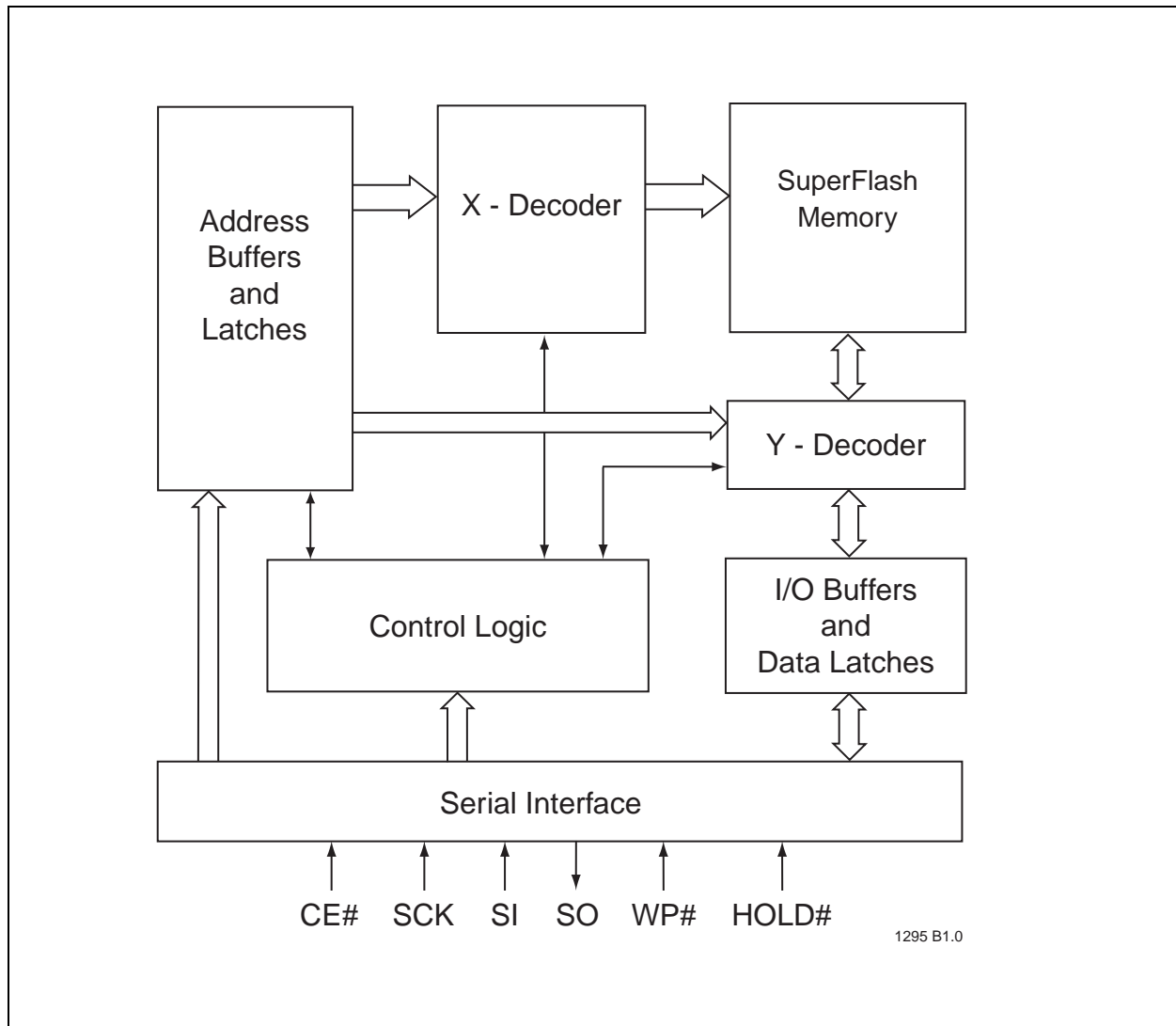
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1.0 BLOCK DIAGRAM

FIGURE 1-1: FUNCTIONAL BLOCK DIAGRAM



2.0 PIN DESCRIPTION

FIGURE 2-1: PIN ASSIGNMENTS

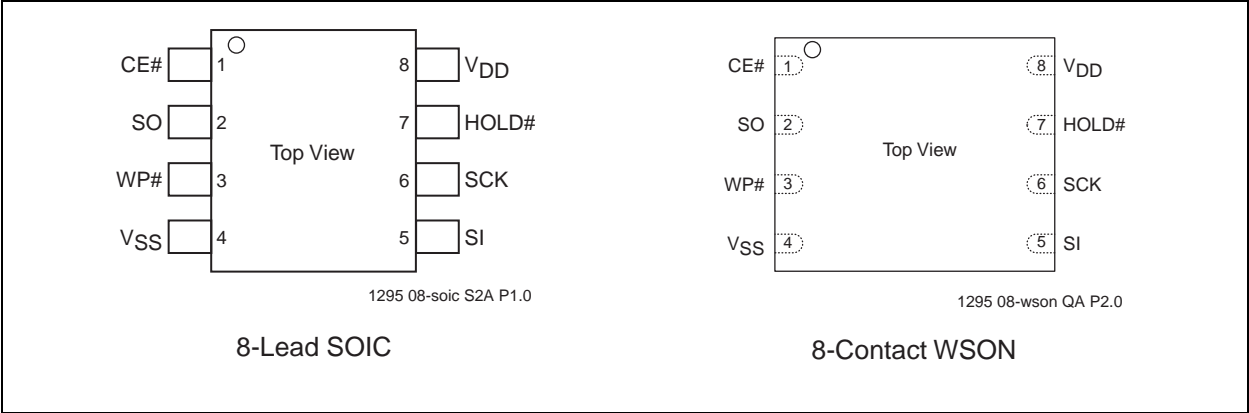


TABLE 2-1: PIN DESCRIPTION

Symbol	Pin Name	Functions
SCK	Serial Clock	To provide the timing of the serial interface. Commands, addresses, or input data are latched on the rising edge of the clock input, while output data is shifted out on the falling edge of the clock input.
SI	Serial Data Input	To transfer commands, addresses, or data serially into the device. Inputs are latched on the rising edge of the serial clock.
SO	Serial Data Output	To transfer data serially out of the device. Data is shifted out on the falling edge of the serial clock. Outputs Flash busy status during AAI Programming when reconfigured as RY/BY# pin. See “Hardware End-of-Write Detection” on page 11 for details.
CE#	Chip Enable	The device is enabled by a high to low transition on CE#. CE# must remain low for the duration of any command sequence.
WP#	Write Protect	The Write Protect (WP#) pin is used to enable/disable BPL bit in the status register.
HOLD#	Hold	To temporarily stop serial communication with SPI flash memory without resetting the device.
V _{DD}	Power Supply	To provide power supply voltage: 2.7-3.6V for SST25VF040B
V _{SS}	Ground	

3.0 MEMORY ORGANIZATION

The SST25VF040B SuperFlash memory array is organized in uniform 4 KByte erasable sectors with 32 KByte overlay blocks and 64 KByte overlay erasable blocks.

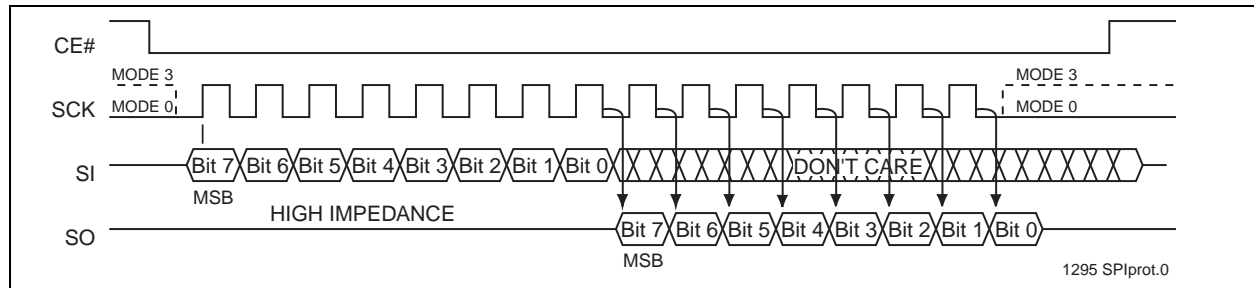
4.0 DEVICE OPERATION

The SST25VF040B is accessed through the SPI (Serial Peripheral Interface) bus compatible protocol. The SPI bus consist of four control lines; Chip Enable (CE#) is

used to select the device, and data is accessed through the Serial Data Input (SI), Serial Data Output (SO), and Serial Clock (SCK).

The SST25VF040B supports both Mode 0 (0,0) and Mode 3 (1,1) of SPI bus operations. The difference between the two modes, as shown in Figure 4-1, is the state of the SCK signal when the bus master is in Stand-by mode and no data is being transferred. The SCK signal is low for Mode 0 and SCK signal is high for Mode 3. For both modes, the Serial Data In (SI) is sampled at the rising edge of the SCK clock signal and the Serial Data Output (SO) is driven after the falling edge of the SCK clock signal.

FIGURE 4-1: SPI PROTOCOL



4.1 Hold Operation

The HOLD# pin is used to pause a serial sequence underway with the SPI flash memory without resetting the clocking sequence. To activate the HOLD# mode, CE# must be in active low state. The HOLD# mode begins when the SCK active low state coincides with the falling edge of the HOLD# signal. The HOLD mode ends when the HOLD# signal's rising edge coincides with the SCK active low state.

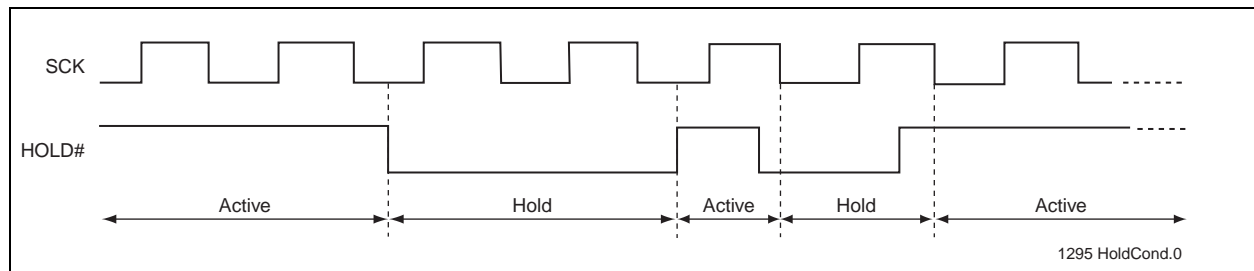
If the falling edge of the HOLD# signal does not coincide with the SCK active low state, then the device enters Hold mode when the SCK next reaches the active low state. Similarly, if the rising edge of the

HOLD# signal does not coincide with the SCK active low state, then the device exits in Hold mode when the SCK next reaches the active low state. See Figure 4-2 for Hold Condition waveform.

Once the device enters Hold mode, SO will be in high-impedance state while SI and SCK can be V_{IL} or V_{IH} .

If CE# is driven active high during a Hold condition, it resets the internal logic of the device. As long as HOLD# signal is low, the memory remains in the Hold condition. To resume communication with the device, HOLD# must be driven active high, and CE# must be driven active low. See Figure 5-3 for Hold timing.

FIGURE 4-2: HOLD CONDITION WAVEFORM



4.2 Write Protection

SST25VF040B provides software Write protection. The Write Protect pin (WP#) enables or disables the lock-down function of the status register. The Block-Protection bits (BP3, BP2, BP1, BP0, and BPL) in the status register provide Write protection to the memory array and the status register. See [Table 4-3](#) for the Block-Protection description.

4.2.1 WRITE PROTECT PIN (WP#)

The Write Protect (WP#) pin enables the lock-down function of the BPL bit (bit 7) in the status register. When WP# is driven low, the execution of the Write-Status-Register (WRSR) instruction is determined by the value of the BPL bit (see [Table 4-1](#)). When WP# is high, the lock-down function of the BPL bit is disabled.

TABLE 4-1: CONDITIONS TO EXECUTE WRITE-STATUS-REGISTER (WRSR) INSTRUCTION

WP#	BPL	Execute WRSR Instruction
L	1	Not Allowed
L	0	Allowed
H	X	Allowed

4.3 Status Register

The software status register provides status on whether the flash memory array is available for any Read or Write operation, whether the device is Write enabled, and the state of the Memory Write protection.

During an internal Erase or Program operation, the status register may be read only to determine the completion of an operation in progress. [Table 4-2](#) describes the function of each bit in the software status register.

TABLE 4-2: SOFTWARE STATUS REGISTER

Bit	Name	Function	Default at Power-up	Read/Write
0	BUSY	1 = Internal Write operation is in progress 0 = No internal Write operation is in progress	0	R
1	WEL	1 = Device is memory Write enabled 0 = Device is not memory Write enabled	0	R
2	BP0	Indicate current level of block write protection (See Table 4-3)	1	R/W
3	BP1	Indicate current level of block write protection (See Table 4-3)	1	R/W
4	BP2	Indicate current level of block write protection (See Table 4-3)	1	R/W
5	BP3	Indicate current level of block write protection (See Table 4-3)	0	R/W
6	AAI	Auto Address Increment Programming status 1 = AAI programming mode 0 = Byte-Program mode	0	R
7	BPL	1 = BP3, BP2, BP1, BP0 are read-only bits 0 = BP3, BP2, BP1, BP0 are read/writable	0	R/W

4.3.1 BUSY

The Busy bit determines whether there is an internal Erase or Program operation in progress. A “1” for the Busy bit indicates the device is busy with an operation in progress. A “0” indicates the device is ready for the next valid operation.

4.3.2 WRITE ENABLE LATCH (WEL)

The Write-Enable-Latch bit indicates the status of the internal memory Write Enable Latch. If the Write-Enable-Latch bit is set to “1”, it indicates the device is Write enabled. If the bit is set to “0” (reset), it indicates the device is not Write enabled and does not accept

any memory Write (Program/Erase) commands. The Write-Enable-Latch bit is automatically reset under the following conditions:

- Power-up
- Write-Disable (WRDI) instruction completion
- Byte-Program instruction completion
- Auto Address Increment (AAI) programming is completed or reached its highest unprotected memory address
- Sector-Erase instruction completion
- Block-Erase instruction completion
- Chip-Erase instruction completion
- Write-Status-Register instructions

4.3.3 AUTO ADDRESS INCREMENT (AAI)

The Auto Address Increment Programming-Status bit provides status on whether the device is in AAI programming mode or Byte-Program mode. The default at power up is Byte-Program mode.

4.3.4 BLOCK PROTECTION (BP3,BP2, BP1, BP0)

The Block-Protection (BP3, BP2, BP1, BP0) bits define the size of the memory area, as defined in [Table 4-3](#), to be software protected against any memory Write (Program or Erase) operation. The Write-Status-Register (WRSR) instruction is used to program the BP3, BP2,

BP1 and BP0 bits as long as WP# is high or the Block-Protect-Lock (BPL) bit is 0. Chip-Erase can only be executed if Block-Protection bits are all 0. After power-up, BP3, BP2, BP1 and BP0 are set to 1.

4.3.5 BLOCK PROTECTION LOCK-DOWN (BPL)

WP# pin driven low (V_{IL}), enables the Block-Protection-Lock-Down (BPL) bit. When BPL is set to 1, it prevents any further alteration of the BPL, BP3, BP2, BP1, and BP0 bits. When the WP# pin is driven high (V_{IH}), the BPL bit has no effect and its value is "Don't Care". After power-up, the BPL bit is reset to 0.

TABLE 4-3: SOFTWARE STATUS REGISTER BLOCK PROTECTION FOR SST25VF040B¹

Protection Level	Status Register Bit ²				Protected Memory Address
	BP3	BP2	BP1	BP0	4 Mbit
None	X	0	0	0	None
Upper 1/8	X	0	0	1	70000H-7FFFFH
Upper 1/4	X	0	1	0	60000H-7FFFFH
Upper 1/2	X	0	1	1	40000H-7FFFFH
All Blocks	X	1	0	0	00000H-7FFFFH
All Blocks	X	1	0	1	00000H-7FFFFH
All Blocks	X	1	1	0	00000H-7FFFFH
All Blocks	X	1	1	1	00000H-7FFFFH

1. X = Don't Care (RESERVED) default is "0"

2. Default at power-up for BP2, BP1, and BP0 is '111'. (All Blocks Protected)

4.4 Instructions

Instructions are used to read, write (Erase and Program), and configure the SST25VF040B. The instruction bus cycles are 8 bits each for commands (Op Code), data, and addresses. Prior to executing any Byte-Program, Auto Address Increment (AAI) programming, Sector-Erase, Block-Erase, Write-Status-Register, or Chip-Erase instructions, the Write-Enable (WREN) instruction must be executed first. The complete list of instructions is provided in [Table 4-4](#). All instructions are synchronized off a high to low transition

of CE#. Inputs will be accepted on the rising edge of SCK starting with the most significant bit. CE# must be driven low before an instruction is entered and must be driven high after the last bit of the instruction has been shifted in (except for Read, Read-ID, and Read-Status-Register instructions). Any low to high transition on CE#, before receiving the last bit of an instruction bus cycle, will terminate the instruction in progress and return the device to standby mode. Instruction commands (Op Code), addresses, and data are all input from the most significant bit (MSB) first.

TABLE 4-4: DEVICE OPERATION INSTRUCTIONS

Instruction	Description	Op Code Cycle ¹	Address Cycle(s) ²	Dummy Cycle(s)	Data Cycle(s)
Read	Read Memory	0000 0011b (03H)	3	0	1 to ∞
High-Speed Read	Read Memory at higher speed	0000 1011b (0BH)	3	1	1 to ∞
4 KByte Sector-Erase ³	Erase 4 KByte of memory array	0010 0000b (20H)	3	0	0
32 KByte Block-Erase ⁴	Erase 32 KByte block of memory array	0101 0010b (52H)	3	0	0
64 KByte Block-Erase ⁵	Erase 64 KByte block of memory array	1101 1000b (D8H)	3	0	0
Chip-Erase	Erase Full Memory Array	0110 0000b (60H) or 1100 0111b (C7H)	0	0	0
Byte-Program	To Program One Data Byte	0000 0010b (02H)	3	0	1
AAI-Word-Program ⁶	Auto Address Increment Programming	1010 1101b (ADH)	3	0	2 to ∞
RDSR ⁷	Read-Status-Register	0000 0101b (05H)	0	0	1 to ∞
EWSR	Enable-Write-Status-Register	0101b 0000b (50H)	0	0	0
WRSR	Write-Status-Register	0000 0001b (01H)	0	0	1
WREN	Write-Enable	0000 0110b (06H)	0	0	0
WRDI	Write-Disable	0000 0100b (04H)	0	0	0
RDID ⁸	Read-ID	1001 0000b (90H) or 1010 1011b (ABH)	3	0	1 to ∞
JEDEC-ID	JEDEC ID read	1001 1111b (9FH)	0	0	3 to ∞
EBSY	Enable SO to output RY/BY# status during AAI programming	0111 0000b (70H)	0	0	0
DBSY	Disable SO as RY/BY# status during AAI programming	1000 0000b (80H)	0	0	0

- One bus cycle is eight clock periods.
- Address bits above the most significant bit of each density can be V_{IL} or V_{IH}.
- 4KByte Sector Erase addresses: use A_{MS}-A₁₂, remaining addresses are don't care but must be set either at V_{IL} or V_{IH}.
- 32KByte Block Erase addresses: use A_{MS}-A₁₅, remaining addresses are don't care but must be set either at V_{IL} or V_{IH}.
- 64KByte Block Erase addresses: use A_{MS}-A₁₆, remaining addresses are don't care but must be set either at V_{IL} or V_{IH}.
- To continue programming to the next sequential address location, enter the 8-bit command, ADH, followed by 2 bytes of data to be programmed. Data Byte 0 will be programmed into the initial address [A₂₃-A₁] with A₀=0, Data Byte 1 will be programmed into the initial address [A₂₃-A₁] with A₀=1.
- The Read-Status-Register is continuous with ongoing clock cycles until terminated by a low to high transition on CE#.
- Manufacturer's ID is read with A₀=0, and Device ID is read with A₀=1. All other address bits are 00H. The Manufacturer's ID and device ID output stream is continuous until terminated by a low-to-high transition on CE#.

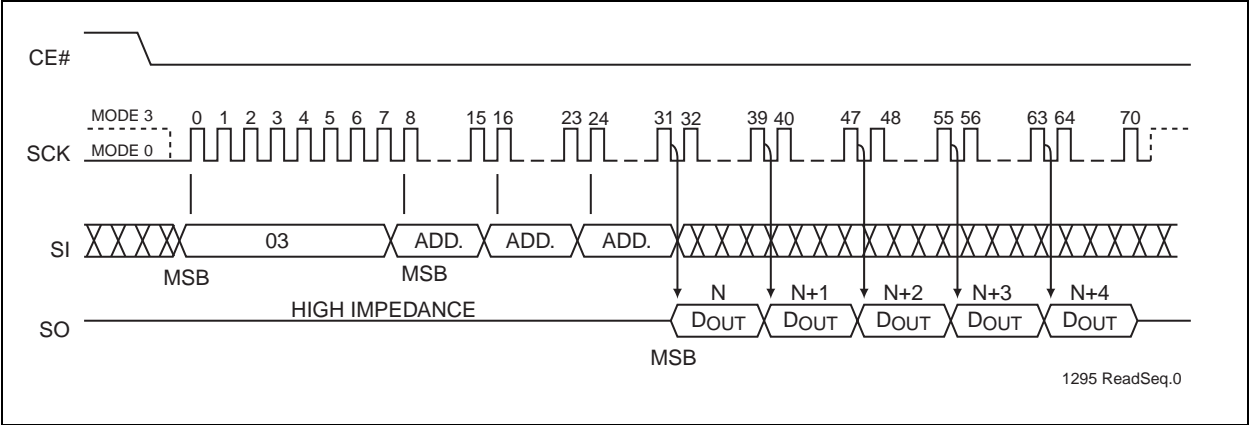
4.4.1 READ (25 MHZ)

The Read instruction, 03H, supports up to 25 MHz Read. The device outputs the data starting from the specified address location. The data output stream is continuous through all addresses until terminated by a low to high transition on CE#. The internal address pointer will automatically increment until the highest memory address is reached. Once the highest memory address is reached, the address pointer will automati-

cally increment to the beginning (wrap-around) of the address space. Once the data from address location 1FFFFFH has been read, the next output will be from address location 000000H.

The Read instruction is initiated by executing an 8-bit command, 03H, followed by address bits [A₂₃-A₀]. CE# must remain active low for the duration of the Read cycle. See Figure 4-3 for the Read sequence.

FIGURE 4-3: READ SEQUENCE



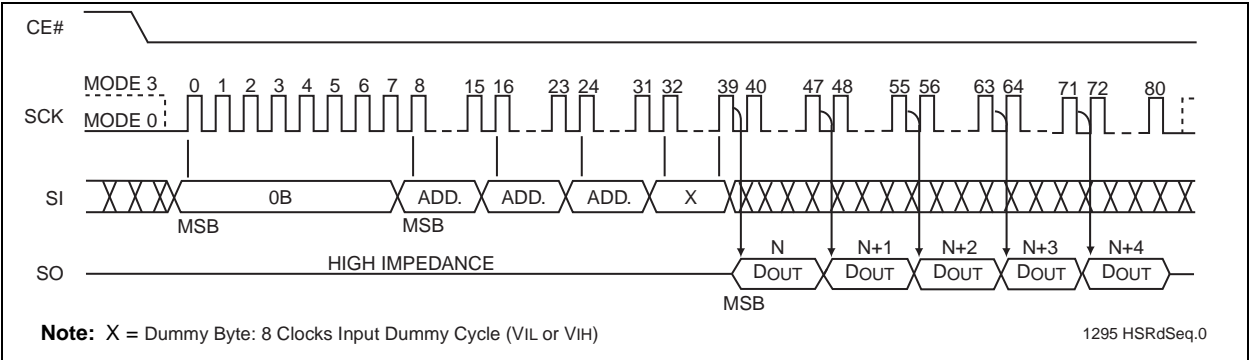
4.4.2 HIGH-SPEED-READ (50 MHZ)

The High-Speed-Read instruction supporting up to 50 MHz Read is initiated by executing an 8-bit command, 0BH, followed by address bits [A₂₃-A₀] and a dummy byte. CE# must remain active low for the duration of the High-Speed-Read cycle. See Figure 4-4 for the High-Speed-Read sequence.

Following a dummy cycle, the High-Speed-Read instruction outputs the data starting from the specified address location. The data output stream is continuous

through all addresses until terminated by a low to high transition on CE#. The internal address pointer will automatically increment until the highest memory address is reached. Once the highest memory address is reached, the address pointer will automatically increment to the beginning (wrap-around) of the address space. Once the data from address location 7FFFFH has been read, the next output will be from address location 00000H.

FIGURE 4-4: HIGH-SPEED-READ SEQUENCE



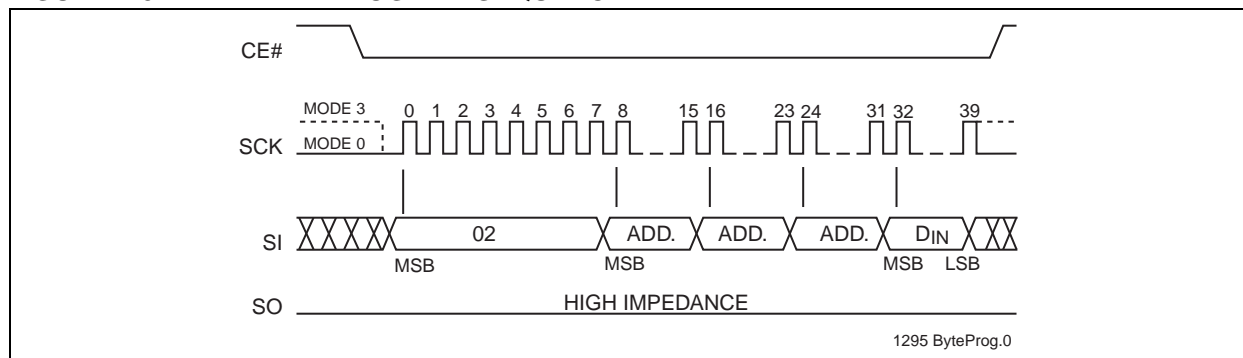
4.4.3 BYTE-PROGRAM

The Byte-Program instruction programs the bits in the selected byte to the desired data. The selected byte must be in the erased state (FFH) when initiating a Program operation. A Byte-Program instruction applied to a protected memory area will be ignored.

Prior to any Write operation, the Write-Enable (WREN) instruction must be executed. CE# must remain active low for the duration of the Byte-Program instruction.

The Byte-Program instruction is initiated by executing an 8-bit command, 02H, followed by address bits [A₂₃-A₀]. Following the address, the data is input in order from MSB (bit 7) to LSB (bit 0). CE# must be driven high before the instruction is executed. The user may poll the Busy bit in the software status register or wait T_{BP} for the completion of the internal self-timed Byte-Program operation. See Figure 4-5 for the Byte-Program sequence.

FIGURE 4-5: BYTE-PROGRAM SEQUENCE



4.4.4 AUTO ADDRESS INCREMENT (AAI) WORD-PROGRAM

The AAI program instruction allows multiple bytes of data to be programmed without re-issuing the next sequential address location. This feature decreases total programming time when multiple bytes or entire memory array is to be programmed. An AAI Word program instruction pointing to a protected memory area will be ignored. The selected address range must be in the erased state (FFH) when initiating an AAI Word Program operation. While within AAI Word Programming sequence, only the following instructions are valid: for software end-of-write detection—AAI Word (ADH), WRDI (04H), and RDSR (05H); for hardware end-of-write detection—AAI Word (ADH) and WRDI (04H). There are three options to determine the completion of each AAI Word program cycle: hardware detection by reading the Serial Output, software detection by polling the BUSY bit in the software status register, or wait T_{BP}. Refer to "End-of-Write Detection" for details.

Prior to any write operation, the Write-Enable (WREN) instruction must be executed. Initiate the AAI Word Program instruction by executing an 8-bit command, ADH, followed by address bits [A₂₃-A₀]. Following the addresses, two bytes of data are input sequentially, each one from MSB (Bit 7) to LSB (Bit 0). The first byte of data (D0) is programmed into the initial address [A₂₃-A₁] with A₀=0, the second byte of Data (D1) is programmed into the initial address [A₂₃-A₁] with A₀=1. CE# must be driven high before executing the AAI Word Program instruction. Check the BUSY status before entering the next valid command. Once the

device indicates it is no longer busy, data for the next two sequential addresses may be programmed, followed by the next two, and so on.

When programming the last desired word, or the highest unprotected memory address, check the busy status using either the hardware or software (RDSR instruction) method to check for program completion. Once programming is complete, use the applicable method to terminate AAI. If the device is in Software End-of-Write Detection mode, execute the Write-Disable (WRDI) instruction, 04H. If the device is in AAI Hardware End-of-Write Detection mode, execute the Write-Disable (WRDI) instruction, 04H, followed by the 8-bit DBSY command, 80H. There is no wrap mode during AAI programming once the highest unprotected memory address is reached. See Figures 4-8 and 4-9 for the AAI Word programming sequence.

4.4.5 END-OF-WRITE DETECTION

There are three methods to determine completion of a program cycle during AAI Word programming: hardware detection by reading the Serial Output, software detection by polling the BUSY bit in the Software Status Register, or wait T_{BP}. The Hardware End-of-Write detection method is described in the section below.

4.4.6 HARDWARE END-OF-WRITE DETECTION

The Hardware End-of-Write detection method eliminates the overhead of polling the Busy bit in the Software Status Register during an AAI Word program operation. The 8-bit command, 70H, configures the Serial Output (SO) pin to indicate Flash Busy status during AAI Word programming. (see Figure 4-6) The 8-bit command, 70H, must be executed prior to initiating an AAI Word-Program instruction. Once an internal programming operation begins, asserting CE# will immediately drive the status of the internal flash status

on the SO pin. A '0' indicates the device is busy and a '1' indicates the device is ready for the next instruction. De-asserting CE# will return the SO pin to tri-state. While in AAI and Hardware End-of-Write detection mode, the only valid instructions are AAI Word (ADH) and WRDI (04H).

To exit AAI Hardware End-of-Write detection, first execute WRDI instruction, 04H, to reset the Write-Enable-Latch bit (WEL=0) and AAI bit. Then execute the 8-bit DBSY command, 80H, to disable RY/BY# status during the AAI command. See Figures 4-7 and 4-8.

FIGURE 4-6: ENABLE SO AS HARDWARE RY/BY# DURING AAI PROGRAMMING

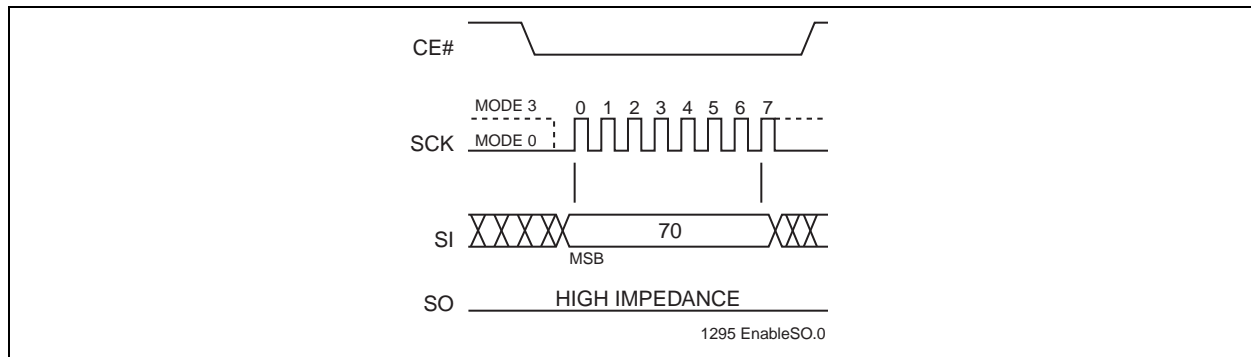


FIGURE 4-7: DISABLE SO AS HARDWARE RY/BY# DURING AAI PROGRAMMING

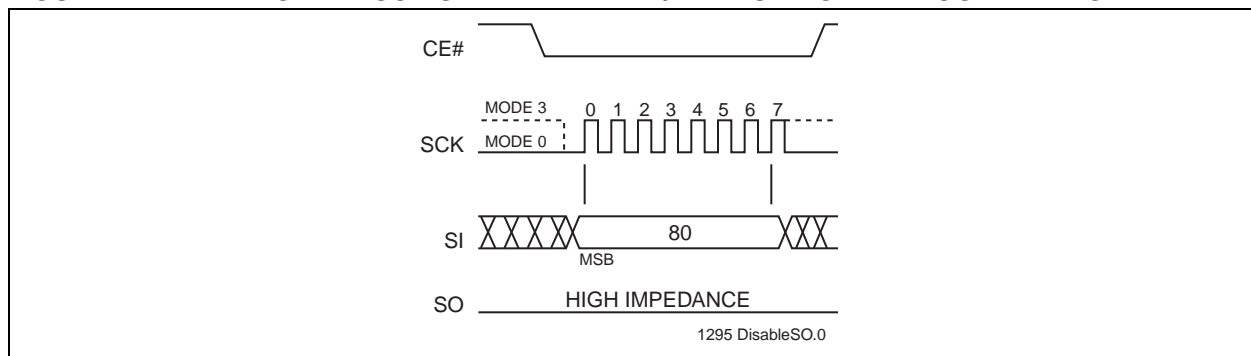


FIGURE 4-8: AUTO ADDRESS INCREMENT (AAI) WORD-PROGRAM SEQUENCE WITH HARDWARE END-OF-WRITE DETECTION

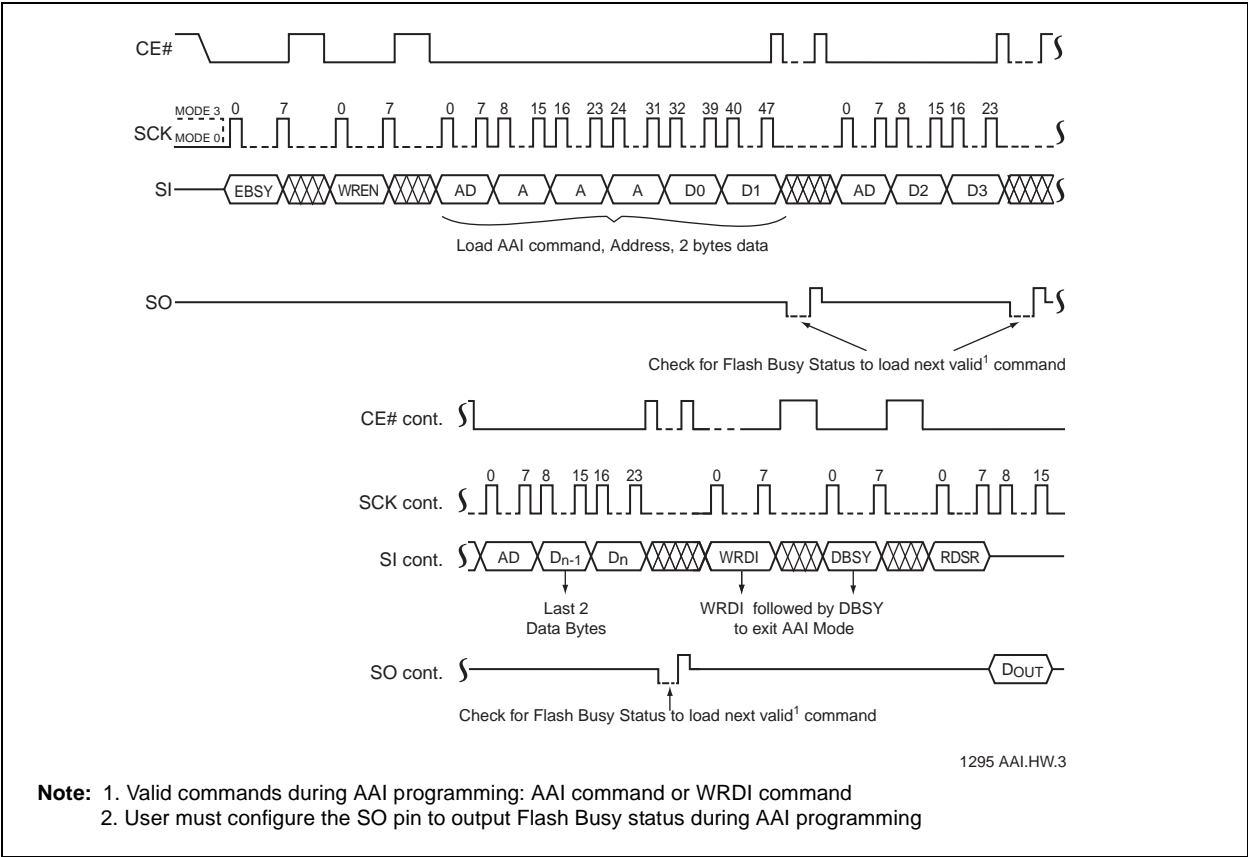
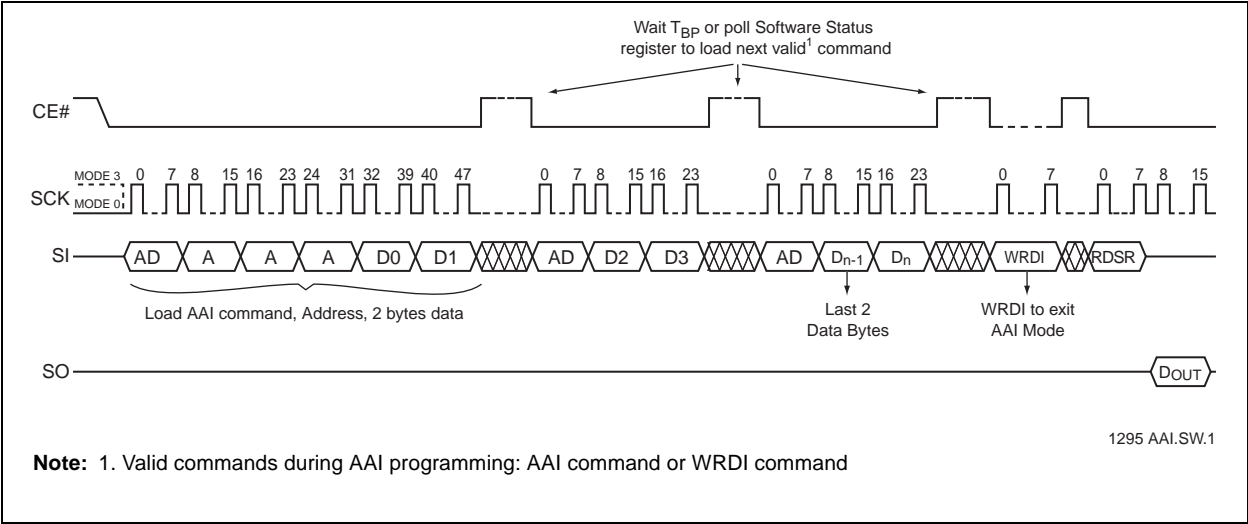


FIGURE 4-9: AUTO ADDRESS INCREMENT (AAI) WORD-PROGRAM SEQUENCE WITH SOFTWARE END-OF-WRITE DETECTION

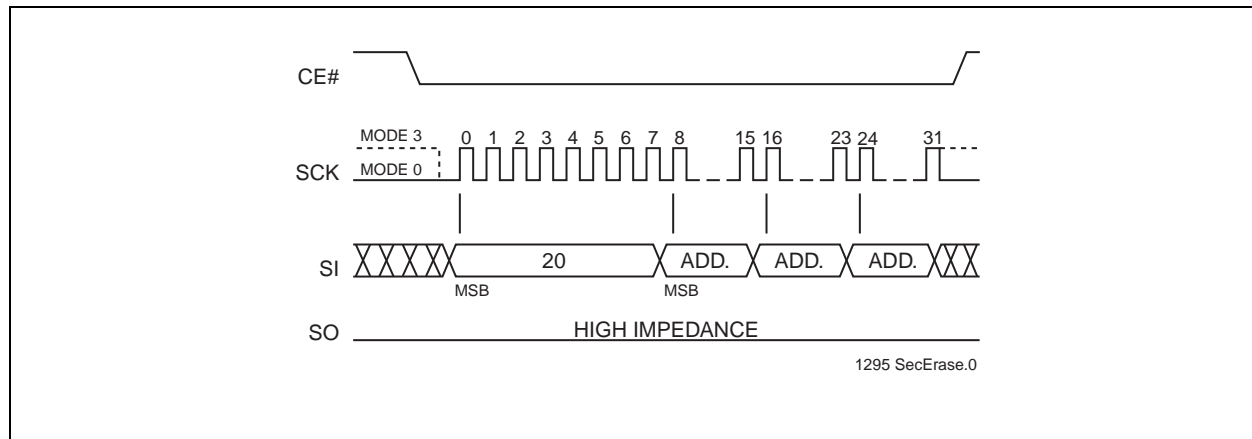


4.4.7 4-KBYTE SECTOR-ERASE

The Sector-Erase instruction clears all bits in the selected 4 KByte sector to FFH. A Sector-Erase instruction applied to a protected memory area will be ignored. Prior to any Write operation, the Write-Enable (WREN) instruction must be executed. CE# must remain active low for the duration of any command sequence. The Sector-Erase instruction is initiated by executing an 8-bit command, 20H, followed by address

bits [A₂₃-A₀]. Address bits [A_{MS}-A₁₂] (A_{MS} = Most Significant address) are used to determine the sector address (SA_X), remaining address bits can be V_{IL} or V_{IH}. CE# must be driven high before the instruction is executed. The user may poll the Busy bit in the software status register or wait T_{SE} for the completion of the internal self-timed Sector-Erase cycle. See Figure 4-10 for the Sector-Erase sequence.

FIGURE 4-10: SECTOR-ERASE SEQUENCE



4.4.8 32-KBYTE AND 64-KBYTE BLOCK-ERASE

The 32-KByte Block-Erase instruction clears all bits in the selected 32 KByte block to FFH. A Block-Erase instruction applied to a protected memory area will be ignored. The 64-KByte Block-Erase instruction clears all bits in the selected 64 KByte block to FFH. A Block-Erase instruction applied to a protected memory area will be ignored. Prior to any Write operation, the Write-Enable (WREN) instruction must be executed. CE# must remain active low for the duration of any command sequence. The 32-KByte Block-Erase instruction is initiated by executing an 8-bit command, 52H, followed by address

bits [A₂₃-A₀]. Address bits [A_{MS}-A₁₅] (A_{MS} = Most Significant Address) are used to determine block address (BA_X), remaining address bits can be V_{IL} or V_{IH}. CE# must be driven high before the instruction is executed. The 64-KByte Block-Erase instruction is initiated by executing an 8-bit command D8H, followed by address bits [A₂₃-A₀]. Address bits [A_{MS}-A₁₆] are used to determine block address (BA_X), remaining address bits can be V_{IL} or V_{IH}. CE# must be driven high before the instruction is executed. The user may poll the Busy bit in the software status register or wait T_{BE} for the completion of the internal self-timed 32-KByte Block-Erase or 64-KByte Block-Erase cycles. See Figures 4-11 and 4-12 for the 32-KByte Block-Erase and 64-KByte Block-Erase sequences.

FIGURE 4-11: 32-KBYTE BLOCK-ERASE SEQUENCE

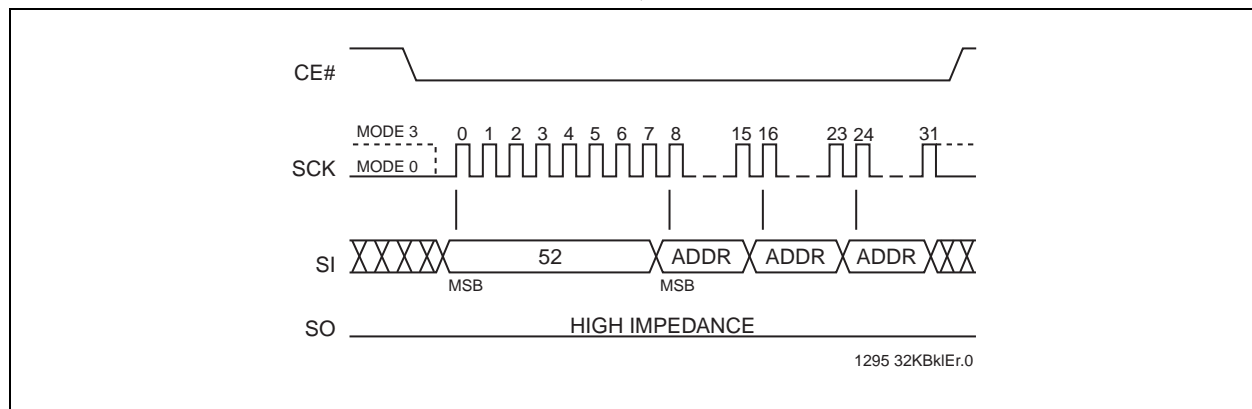
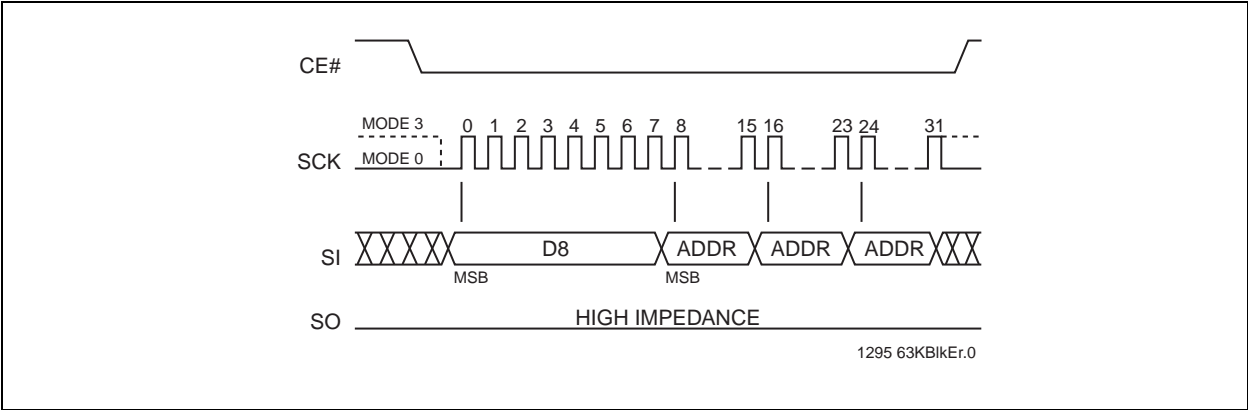


FIGURE 4-12: 64-KBYTE BLOCK-ERASE SEQUENCE

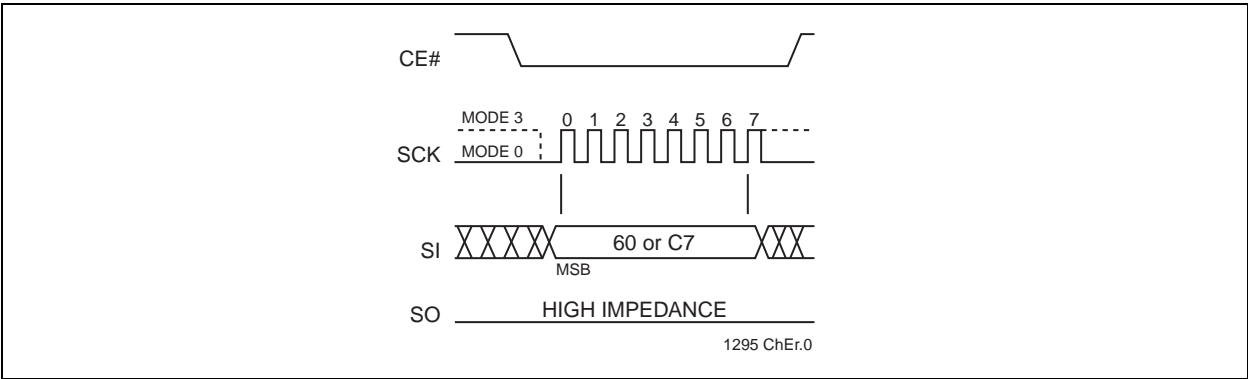


4.4.9 CHIP-ERASE

The Chip-Erase instruction clears all bits in the device to FFH. A Chip-Erase instruction will be ignored if any of the memory area is protected. Prior to any Write operation, the Write-Enable (WREN) instruction must be executed. CE# must remain active low for the duration of the Chip-Erase instruction sequence. The Chip-Erase

instruction is initiated by executing an 8-bit command, 60H or C7H. CE# must be driven high before the instruction is executed. The user may poll the Busy bit in the software status register or wait T_{CE} for the completion of the internal self-timed Chip-Erase cycle. See Figure 4-13 for the Chip-Erase sequence.

FIGURE 4-13: CHIP-ERASE SEQUENCE

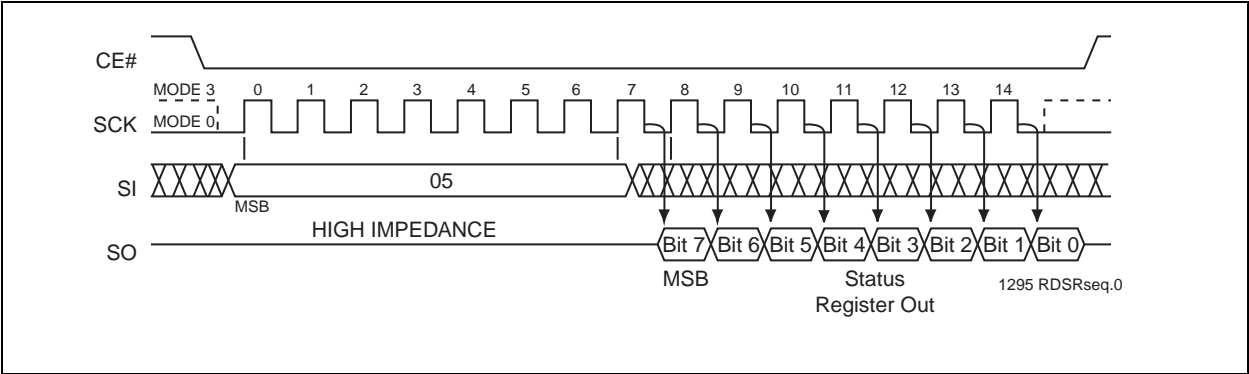


4.4.10 READ-STATUS-REGISTER (RDSR)

The Read-Status-Register (RDSR) instruction allows reading of the status register. The status register may be read at any time even during a Write (Program/Erase) operation. When a Write operation is in progress, the Busy bit may be checked before sending any new commands to assure that the new commands are

properly received by the device. CE# must be driven low before the RDSR instruction is entered and remain low until the status data is read. Read-Status-Register is continuous with ongoing clock cycles until it is terminated by a low to high transition of the CE#. See [Figure 4-14](#) for the RDSR instruction sequence.

FIGURE 4-14: READ-STATUS-REGISTER (RDSR) SEQUENCE

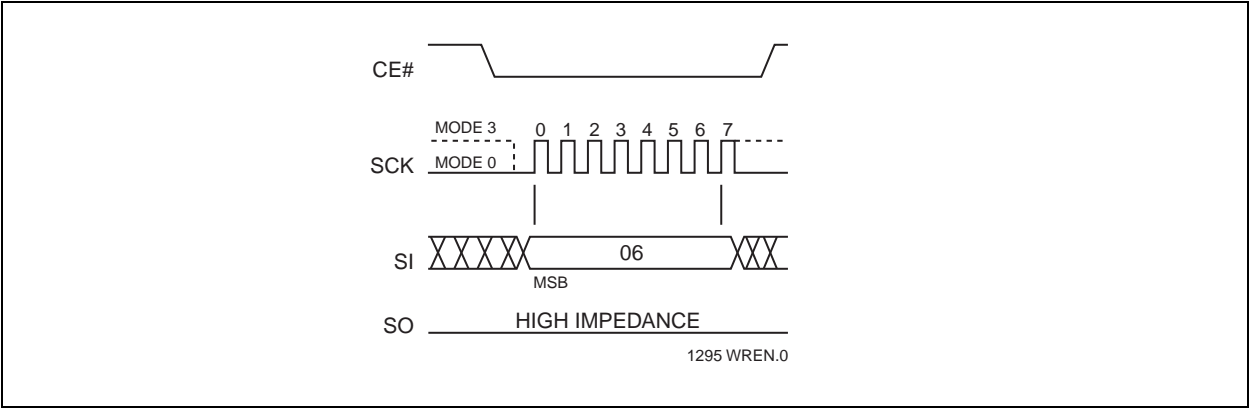


4.4.11 WRITE-ENABLE (WREN)

The Write-Enable (WREN) instruction sets the Write-Enable-Latch bit in the Status Register to 1 allowing Write operations to occur. The WREN instruction must be executed prior to any Write (Program/Erase) operation. The WREN instruction may also be used to allow

execution of the Write-Status-Register (WRSR) instruction; however, the Write-Enable-Latch bit in the Status Register will be cleared upon the rising edge CE# of the WRSR instruction. CE# must be driven high before the WREN instruction is executed.

FIGURE 4-15: WRITE ENABLE (WREN) SEQUENCE



4.4.12 WRITE-DISABLE (WRDI)

The Write-Disable (WRDI) instruction resets the Write-Enable-Latch bit and AAI bit to 0 disabling any new Write operations from occurring. The WRDI instruction will not terminate any programming operation in prog-

ress. Any program operation in progress may continue up to T_{BP} after executing the WRDI instruction. CE# must be driven high before the WRDI instruction is executed.

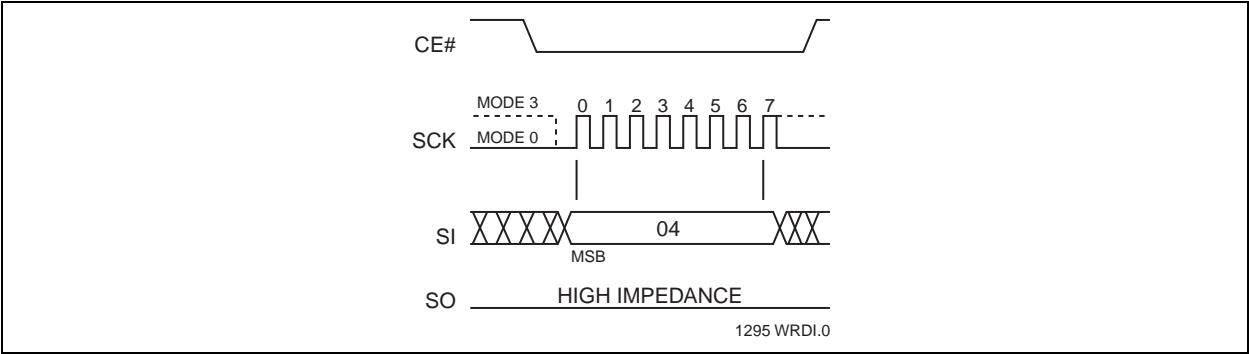


FIGURE 4-16: WRITE DISABLE (WRDI) SEQUENCE

4.4.13 ENABLE-WRITE-STATUS-REGISTER (EWSR)

The Enable-Write-Status-Register (EWSR) instruction arms the Write-Status-Register (WRSR) instruction and opens the status register for alteration. The Write-Status-Register instruction must be executed immediately after the execution of the Enable-Write-Status-Register instruction. This two-step instruction sequence of the EWSR instruction followed by the WRSR instruction works like SDP (software data protection) command structure which prevents any accidental alteration of the status register values. CE# must be driven low before the EWSR instruction is entered and must be driven high before the EWSR instruction is executed.

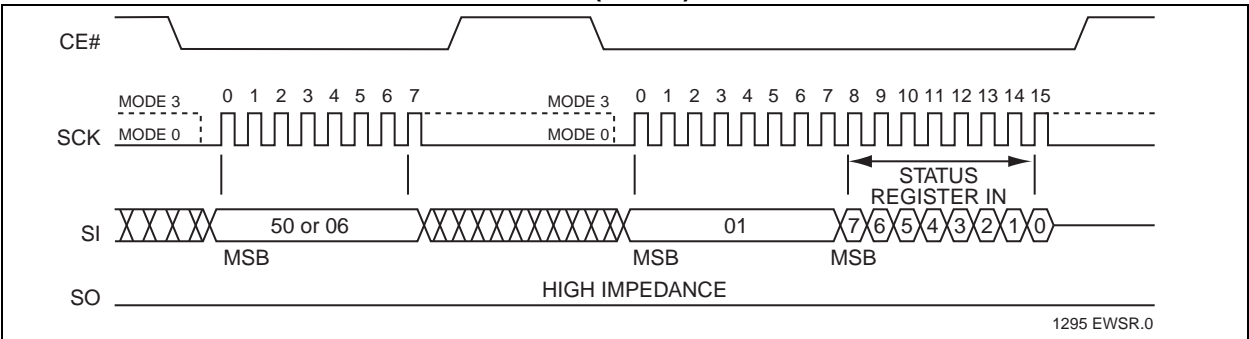
command sequence of the WRSR instruction is entered and driven high before the WRSR instruction is executed. See Figure 4-17 for EWSR or WREN and WRSR instruction sequences.

Executing the Write-Status-Register instruction will be ignored when WP# is low and BPL bit is set to “1”. When the WP# is low, the BPL bit can only be set from “0” to “1” to lock-down the status register, but cannot be reset from “1” to “0”. When WP# is high, the lock-down function of the BPL bit is disabled and the BPL, BP0, and BP1 and BP2 bits in the status register can all be changed. As long as BPL bit is set to 0 or WP# pin is driven high (V_{IH}) prior to the low-to-high transition of the CE# pin at the end of the WRSR instruction, the bits in the status register can all be altered by the WRSR instruction. In this case, a single WRSR instruction can set the BPL bit to “1” to lock down the status register as well as altering the BP0, BP1, and BP2 bits at the same time. See Table 4-1 for a summary description of WP# and BPL functions.

4.4.14 WRITE-STATUS-REGISTER (WRSR)

The Write-Status-Register instruction writes new values to the BP3, BP2, BP1, BP0, and BPL bits of the status register. CE# must be driven low before the

FIGURE 4-17: ENABLE-WRITE-STATUS-REGISTER (EWSR) OR WRITE-ENABLE (WREN) AND WRITE-STATUS-REGISTER (WRSR) SEQUENCE



4.4.15 JEDEC READ-ID

The JEDEC Read-ID instruction identifies the device as SST25VF040B and the manufacturer as Microchip. The device information can be read from executing the 8-bit command, 9FH. Following the JEDEC Read-ID instruction, the 8-bit manufacturer's ID, BFH, is output from the device. After that, a 16-bit device ID is shifted

out on the SO pin. Byte 1, BFH, identifies the manufacturer as Microchip. Byte 2, 25H, identifies the memory type as SPI Serial Flash. Byte 3, 8DH, identifies the device as SST25VF040B. The instruction sequence is shown in Figure 4-18. The JEDEC Read ID instruction is terminated by a low to high transition on CE# at any time during data output.

FIGURE 4-18: JEDEC READ-ID SEQUENCE

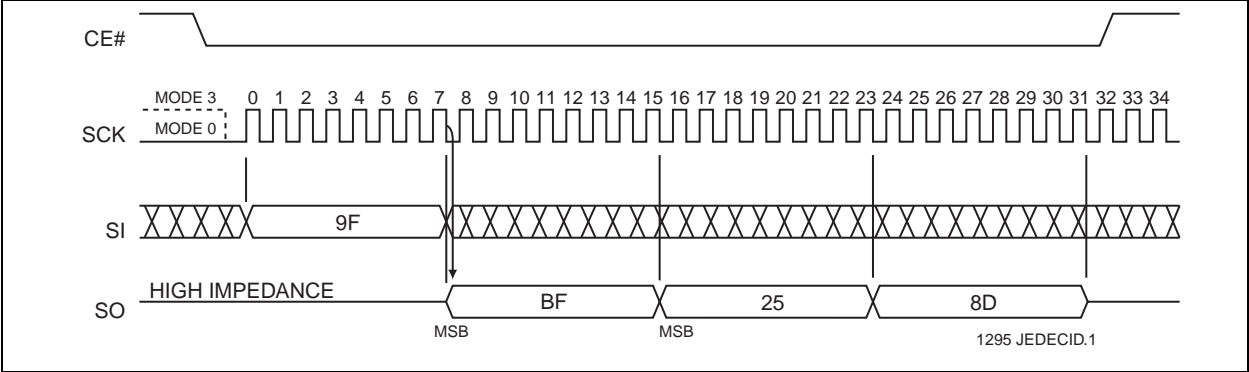


TABLE 4-5: JEDEC READ-ID DATA

Manufacturer's ID	Device ID	
	Memory Type	Memory Capacity
Byte1	Byte 2	Byte 3
BFH	25H	8DH

4.4.16 READ-ID (RDID)

The Read-ID instruction (RDID) identifies the devices as SST25VF040B and manufacturer as Microchip. This command is backward compatible to all SST25xFxxxA devices and should be used as default device identification when multiple versions of SPI Serial Flash devices are used in a design. The device information can be read from executing an 8-bit command, 90H or ABH, followed by address bits [A₂₃-A₀]. Following the

Read-ID instruction, the manufacturer's ID is located in address 00000H and the device ID is located in address 00001H. Once the device is in Read-ID mode, the manufacturer's and device ID output data toggles between address 00000H and 00001H until terminated by a low to high transition on CE#.

Refer to Tables 4-5 and 4-6 for device identification data.

FIGURE 4-19: READ-ID SEQUENCE

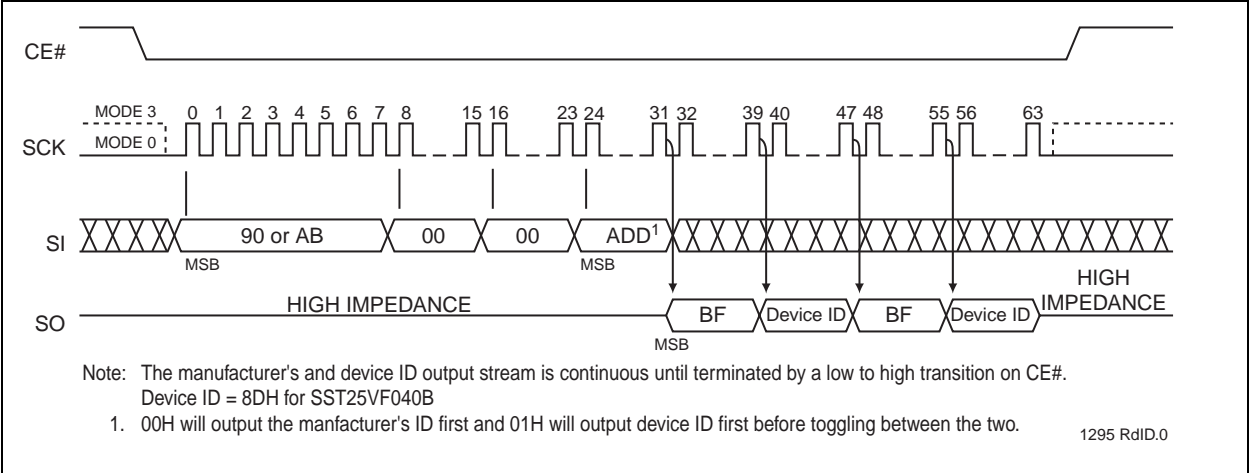


TABLE 4-6: PRODUCT IDENTIFICATION

	Address	Data
Manufacturer's ID	00000H	BFH
Device ID		
SST25VF040B	00001H	8DH

5.0 ELECTRICAL SPECIFICATIONS

Absolute Maximum Stress Ratings (Applied conditions greater than those listed under “Absolute Maximum Stress Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these conditions or conditions greater than those defined in the operational sections of this data sheet is not implied. Exposure to absolute maximum stress rating conditions may affect device reliability.)

Temperature Under Bias	-55°C to +125°C
Storage Temperature	-65°C to +150°C
D. C. Voltage on Any Pin to Ground Potential	-0.5V to $V_{DD}+0.5V$
Transient Voltage (<20 ns) on Any Pin to Ground Potential	-2.0V to $V_{DD}+2.0V$
Package Power Dissipation Capability ($T_A = 25^\circ\text{C}$)	1.0W
Surface Mount Solder Reflow Temperature	260°C for 10 seconds
Output Short Circuit Current ¹	50 mA

1. Output shorted for no more than one second. No more than one output shorted at a time.

TABLE 5-1: OPERATING RANGE

Range	Ambient Temp	V_{DD}
Commercial	0°C to +70°C	2.7-3.6V
Industrial	-40°C to +85°C	2.7-3.6V

TABLE 5-2: AC CONDITIONS OF TEST¹

Input Rise/Fall Time	Output Load
5ns	$C_L = 30 \text{ pF}$

1. See Figures 5-5 and 5-6

TABLE 5-3: DC OPERATING CHARACTERISTICS

Symbol	Parameter	Limits			Test Conditions
		Min	Max	Units	
I_{DDR}	Read Current		10	mA	$CE\# = 0.1 V_{DD}/0.9 V_{DD}$ @ 25 MHz, SO=open
I_{DDR2}	Read Current		15	mA	$CE\# = 0.1 V_{DD}/0.9 V_{DD}$ @ 50 MHz, SO=open
I_{DDW}	Program and Erase Current		30	mA	$CE\# = V_{DD}$
I_{SB}	Standby Current		20	μA	$CE\# = V_{DD}$, $V_{IN} = V_{DD}$ or V_{SS}
I_{LI}	Input Leakage Current		1	μA	$V_{IN} = \text{GND to } V_{DD}$, $V_{DD} = V_{DD} \text{ Max}$
I_{LO}	Output Leakage Current		1	μA	$V_{OUT} = \text{GND to } V_{DD}$, $V_{DD} = V_{DD} \text{ Max}$
V_{IL}	Input Low Voltage		0.8	V	$V_{DD} = V_{DD} \text{ Min}$
V_{IH}	Input High Voltage	$0.7 V_{DD}$		V	$V_{DD} = V_{DD} \text{ Max}$
V_{OL}	Output Low Voltage		0.2	V	$I_{OL} = 100 \mu\text{A}$, $V_{DD} = V_{DD} \text{ Min}$
V_{OL2}	Output Low Voltage		0.4	V	$I_{OL} = 1.6 \text{ mA}$, $V_{DD} = V_{DD} \text{ Min}$
V_{OH}	Output High Voltage	$V_{DD} - 0.2$		V	$I_{OH} = -100 \mu\text{A}$, $V_{DD} = V_{DD} \text{ Min}$

TABLE 5-4: CAPACITANCE ($T_A = 25^\circ\text{C}$, $F = 1 \text{ MHz}$, OTHER PINS OPEN)

Parameter	Description	Test Condition	Maximum
C_{OUT}^1	Output Pin Capacitance	$V_{OUT} = 0V$	12 pF
C_{IN}^1	Input Capacitance	$V_{IN} = 0V$	6 pF

1. This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

TABLE 5-5: RELIABILITY CHARACTERISTICS

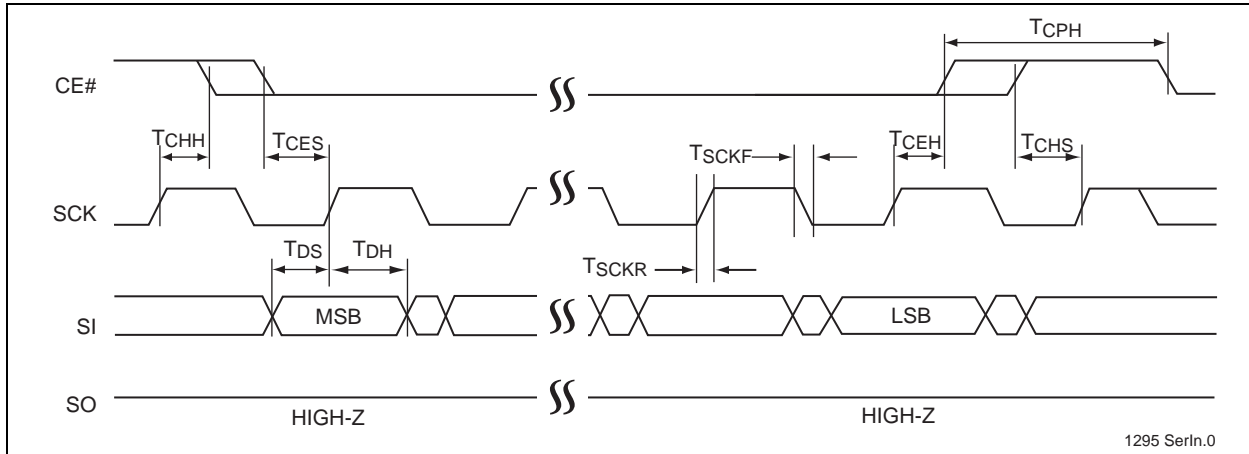
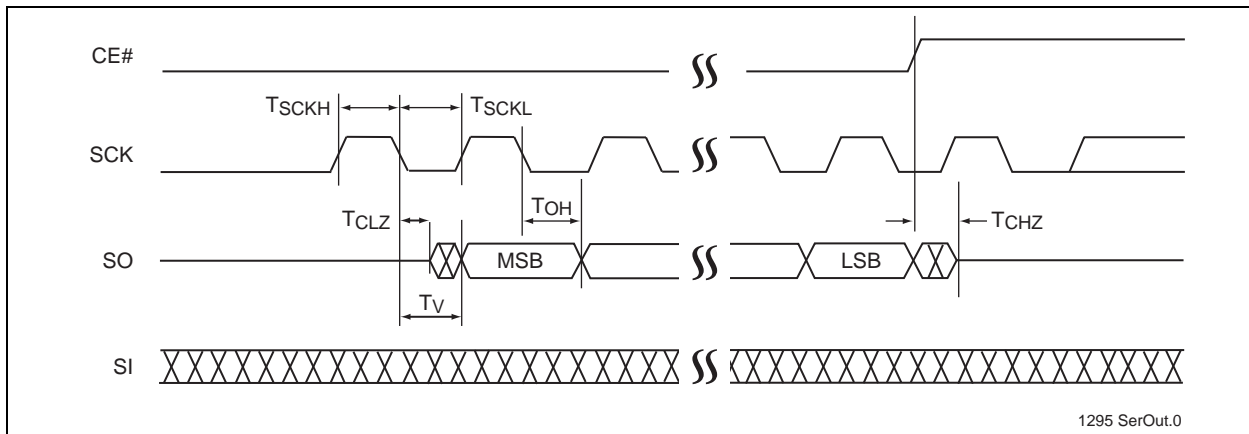
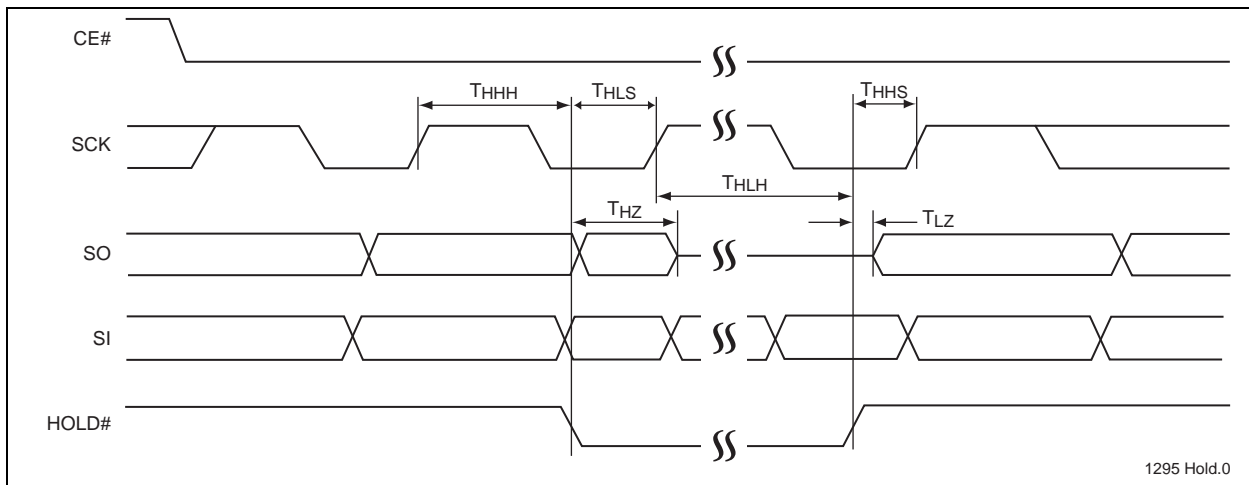
Symbol	Parameter	Minimum Specification	Units	Test Method
N_{END}^1	Endurance	10,000	Cycles	JEDEC Standard A117
T_{DR}^1	Data Retention	100	Years	JEDEC Standard A103
I_{LTH}^1	Latch Up	$100 + I_{DD}$	mA	JEDEC Standard 78

1. This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

TABLE 5-6: AC OPERATING CHARACTERISTICS

Symbol	Parameter	25 MHz		50 MHz		Units
		Min	Max	Min	Max	
F_{CLK}^1	Serial Clock Frequency		25		50	MHz
T_{SCKH}	Serial Clock High Time	18		9		ns
T_{SCKL}	Serial Clock Low Time	18		9		ns
T_{SCKR}^2	Serial Clock Rise Time (Slew Rate)	0.1		0.1		V/ns
T_{SCKF}	Serial Clock Fall Time (Slew Rate)	0.1		0.1		V/ns
T_{CES}^3	CE# Active Setup Time	10		5		ns
T_{CEH}^3	CE# Active Hold Time	10		5		ns
T_{CHS}^3	CE# Not Active Setup Time	10		5		ns
T_{CHH}^3	CE# Not Active Hold Time	10		5		ns
T_{CPH}	CE# High Time	100		50		ns
T_{CHZ}	CE# High to High-Z Output		15		8	ns
T_{CLZ}	SCK Low to Low-Z Output	0		0		ns
T_{DS}	Data In Setup Time	5		2		ns
T_{DH}	Data In Hold Time	5		5		ns
T_{HLS}	HOLD# Low Setup Time	10		5		ns
T_{HHS}	HOLD# High Setup Time	10		5		ns
T_{HLH}	HOLD# Low Hold Time	10		5		ns
T_{HHH}	HOLD# High Hold Time	10		5		ns
T_{HZ}	HOLD# Low to High-Z Output		20		8	ns
T_{LZ}	HOLD# High to Low-Z Output		15		8	ns
T_{OH}	Output Hold from SCK Change	0		0		ns
T_V	Output Valid from SCK		15		8	ns
T_{SE}	Sector-Erase		25		25	ms
T_{BE}	Block-Erase		25		25	ms
T_{SCE}	Chip-Erase		50		50	ms
T_{BP}	Byte-Program		10		10	μs

1. Maximum clock frequency for Read Instruction, 03H, is 25 MHz
2. Maximum Rise and Fall time may be limited by T_{SCKH} and T_{SCKL} requirements
3. Relative to SCK.

FIGURE 5-1: SERIAL INPUT TIMING DIAGRAM**FIGURE 5-2: SERIAL OUTPUT TIMING DIAGRAM****FIGURE 5-3: HOLD TIMING DIAGRAM**

5.1 Power-Up Specifications

All functionalities and DC specifications are specified for a V_{DD} ramp rate of greater than 1V per 100 ms (0v - 3.0V in less than 300 ms). See Table 5-7 and Figure 5-4 for more information.

TABLE 5-7: RECOMMENDED SYSTEM POWER-UP TIMINGS

Symbol	Parameter	Minimum	Units
$T_{PU-READ}^1$	V_{DD} Min to Read Operation	100	μs
$T_{PU-WRITE}^1$	V_{DD} Min to Write Operation	100	μs

1. This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

FIGURE 5-4: POWER-UP TIMING DIAGRAM

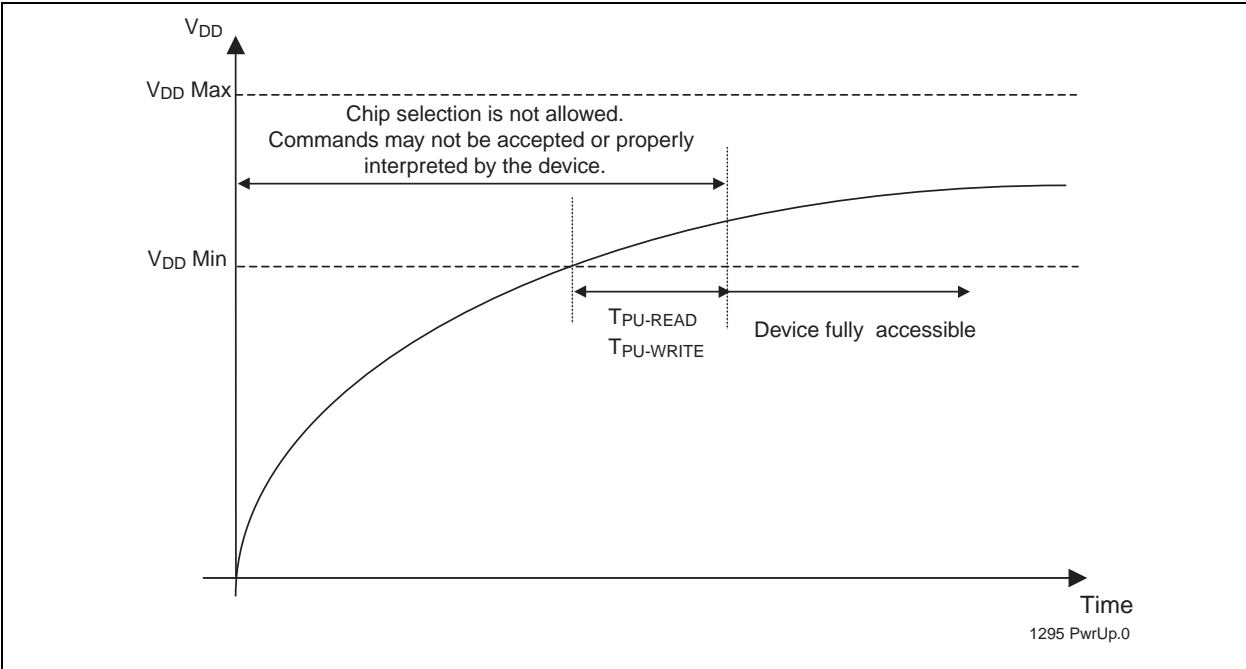


FIGURE 5-5: AC INPUT/OUTPUT REFERENCE WAVEFORMS

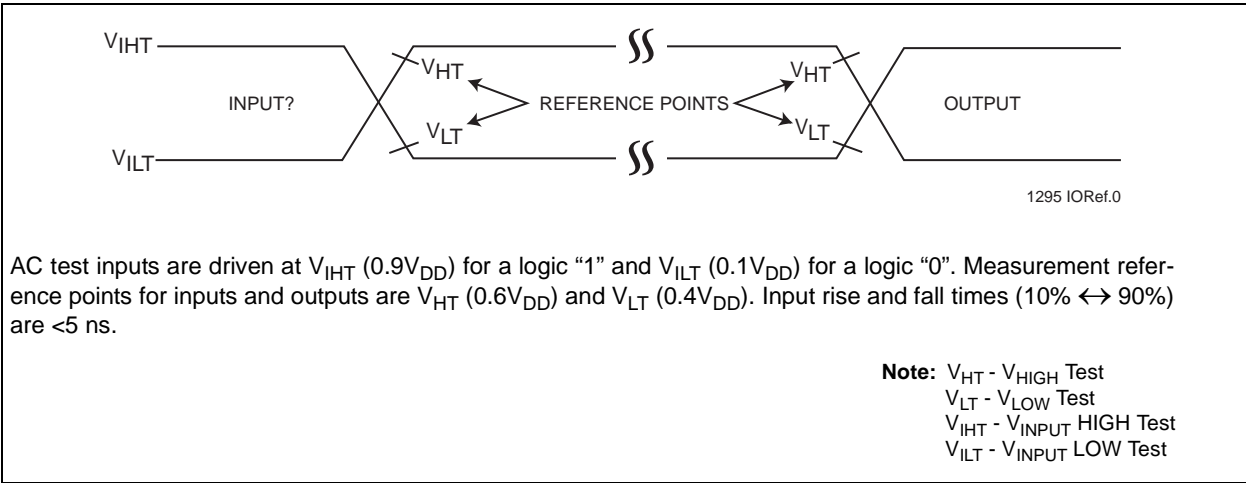
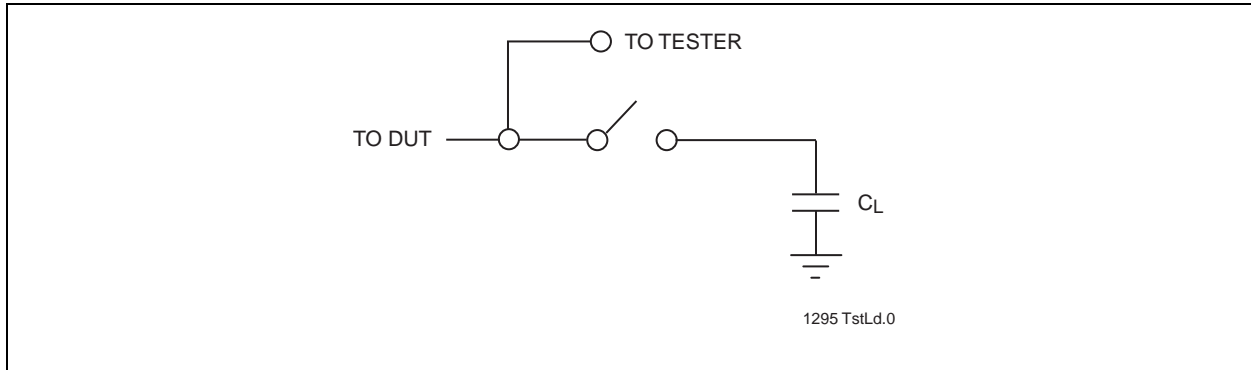
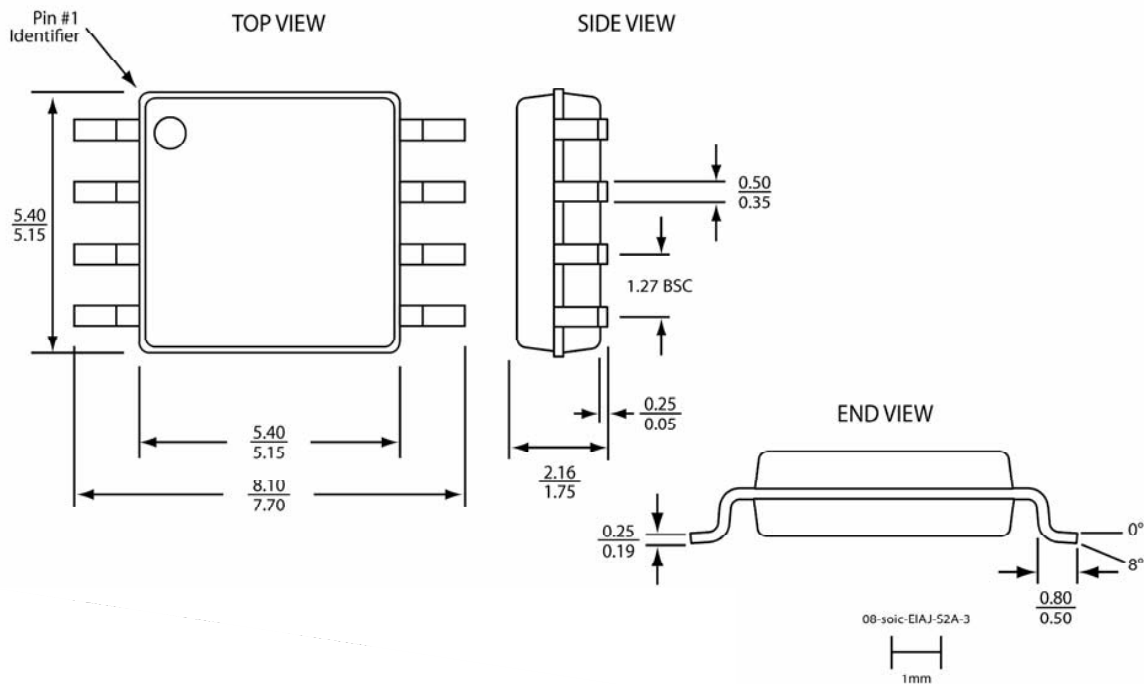


FIGURE 5-6: A TEST LOAD EXAMPLE

6.0 PACKAGING DIAGRAMS

8-Lead Small Outline Integrated Circuit (S2AE/F) - .208 Inch Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>

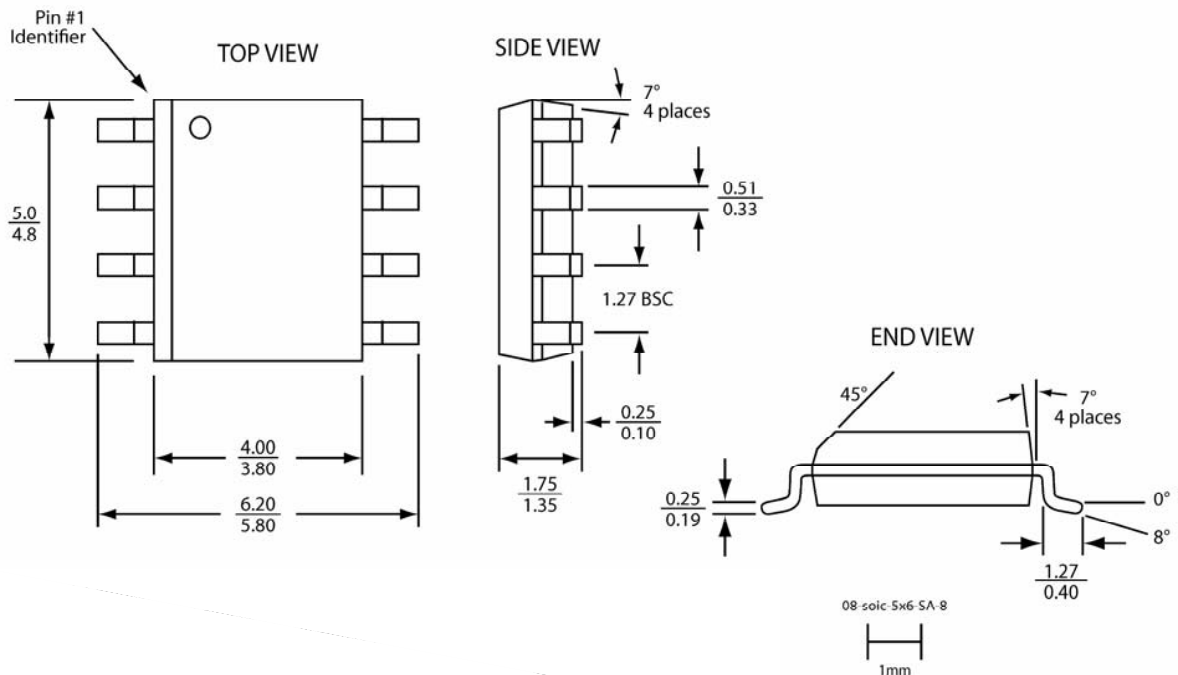


Note:

1. All linear dimensions are in millimeters (max/min).
2. Coplanarity: 0.1 mm
3. Maximum allowable mold flash is 0.15 mm at the package ends and 0.25 mm between leads.

8-Lead Small Outline Integrated Circuit (SAE/F) - 5x6 mm Body [SOIC]

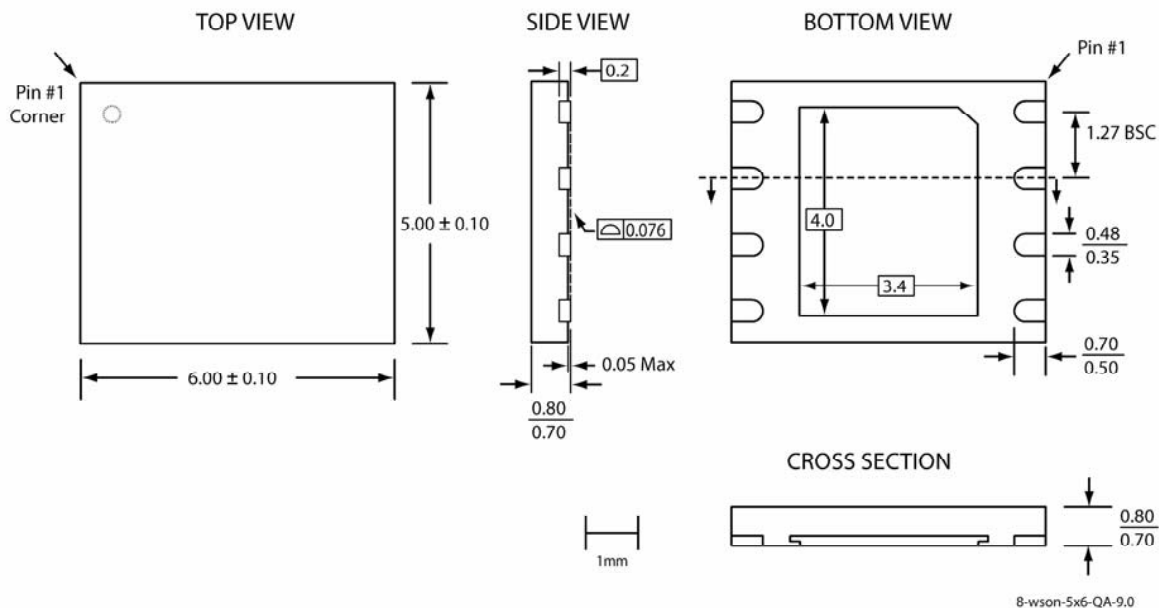
Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>

**Note:**

1. Complies with JEDEC publication 95 MS-012 AA dimensions, although some dimensions may be more stringent.
2. All linear dimensions are in millimeters (max/min).
3. Coplanarity: 0.1 mm
4. Maximum allowable mold flash is 0.15 mm at the package ends and 0.25 mm between leads.

8-Lead Very, Very Thin Small Outline No-Leads (QAE/F) - 5x6 mm Body [WSON]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Note:

1. All linear dimensions are in millimeters (max/min).
2. Untoleranced dimensions (shown with box surround) are nominal target dimensions.
3. The external paddle is electrically connected to the die back-side and possibly to certain VSS leads. This paddle can be soldered to the PC board; it is suggested to connect this paddle to the VSS of the unit. Connection of this paddle to any other voltage potential can result in shorts and/or electrical malfunction of the device.

TABLE 6-1: REVISION HISTORY

Revision	Description	Date
00	<ul style="list-style-type: none"> Initial release of data sheet 	Sep 2005
01	<ul style="list-style-type: none"> Migrated document to a Data Sheet Updated Surface Mount Solder Reflow Temperature information 	Jan 2006
02	<ul style="list-style-type: none"> Added 8-Lead SOIC (150 mils) package drawing. Updated Features and Product Description to include new package information. Updated Pin-Assignment, Figure 2-1 Revised Figure 4-8 and Figure 4-9 	Jul 2007
03	<ul style="list-style-type: none"> Updated document to reflect upgraded clock frequency to 80 MHz globally Updated Features Changed maximum frequency to 80 MHz in Table 4-4 on page 8 Added IDDR3 to Table 5-3 on page 19 Added 80 MHz column to Table 5-6 on page 20 Updated Product Ordering Information and Valid Combinations on page 29 	Mar 2009
04	<ul style="list-style-type: none"> Updated Product Ordering Information and Valid Combinations on page 29 Added "Power-Up Specifications" on page 22 Modified High-Speed-Read values in Table 4-4 on page 8 and "High-Speed-Read (50 MHz)" on page 9 	Jun 2009
05	<ul style="list-style-type: none"> Added 50/33 MHz information throughout. Separated AC and DC Characteristics for SST25VF040B-50-4C-xxxF & SST25VF040B-80-4I-xxxE 	Oct 2009
06	<ul style="list-style-type: none"> Updated "Auto Address Increment (AAI) Word-Program", "End-of-Write Detection", and "Hardware End-of-Write Detection" on page 11. Revised Figures 4-8 and 4-9 on page 12. Updated document to new format. 	Feb 2011
A	<ul style="list-style-type: none"> Removed "Recommended System Power-up Timings" from page 29. Released document under letter revision system. Updated Spec number from S71295 to DS25051 	Sep 2011
B	<ul style="list-style-type: none"> EOL of all 80 MHz parts. Replacement parts are the 50 MHz counterparts found in this document. Removed all 80 MHz information. See DS20005264. Updated document to new format. Replaced all package drawings with drawings in the new format. 	Feb 2014
C	<ul style="list-style-type: none"> Corrected an address bit on page 13 	Jun 2015
D	<ul style="list-style-type: none"> Added Units column and corrected typo in Table 5-6. 	July 2017

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7.0 PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

<u>PART NO.</u>		-	<u>XX</u>	-	<u>XX</u>	-	<u>XX</u>	-	<u>X</u>
Device	Operating Frequency	Minimum Endurance	Temp Range	Package	Tape/Reel Indicator				
Device:	SST25VF040B	= 4 Mbit, 2.7-3.6V, SPI Flash Memory							
Operating Frequency:	50	= 50 MHz							
Minimum Endurance	4	= 10,000 cycles							
Temperature:	I	= -40°C to +85°C							
	C	= 0°C to +70°C							
Package:	QAF/QAE ¹	= WSON (6mm x 5mm Body), 8-lead							
	S2AF/S2AE ¹	= SOIC (200 mil Body), 8-lead							
	SAF/SAE ¹	= SOIC (150 mm Body), 8-lead							
Tape and Reel Flag:	T	= Tape and Reel							
1. Suffix E = Matte Tin finish Suffix F = Nickel plating with Gold top (outer) layer finish									

Valid Combinations:
SST25VF040B-50-4C-SAF
SST25VF040B-50-4C-SAF-T
SST25VF040B-50-4I-SAF
SST25VF040B-50-4I-SAF-T
SST25VF040B-50-4I-SAE
SST25VF040B-50-4I-SAE-T
SST25VF040B-50-4C-S2AF
SST25VF040B-50-4C-S2AF-T
SST25VF040B-50-4I-S2AF
SST25VF040B-50-4I-S2AF-T
SST25VF040B-50-4I-S2AE
SST25VF040B-50-4I-S2AE-T
SST25VF040B-50-4C-QAF
SST25VF040B-50-4C-QAF-T
SST25VF040B-50-4I-QAF
SST25VF040B-50-4I-QAF-T
SST25VF040B-50-4I-QAE
SST25VF040B-50-4I-QAE-T

Valid Combinations:

SST25VF040B-50-4C-SAF
 SST25VF040B-50-4C-SAF-T
 SST25VF040B-50-4I-SAF
 SST25VF040B-50-4I-SAF-T
 SST25VF040B-50-4I-SAE
 SST25VF040B-50-4I-SAE-T

 SST25VF040B-50-4C-S2AF
 SST25VF040B-50-4C-S2AF-T
 SST25VF040B-50-4I-S2AF
 SST25VF040B-50-4I-S2AF-T
 SST25VF040B-50-4I-S2AE
 SST25VF040B-50-4I-S2AE-T

 SST25VF040B-50-4C-QAF
 SST25VF040B-50-4C-QAF-T
 SST25VF040B-50-4I-QAF
 SST25VF040B-50-4I-QAF-T
 SST25VF040B-50-4I-QAE
 SST25VF040B-50-4I-QAE-T

NOTES:

Note the following details of the code protection feature on Microchip devices:

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- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
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